



Process Change Notification

PCN Number: PCN-2016-63

PCN Notification Date: 09/30/2016

Initial PCN

STATS ChipPAC* Assembly Site Transfer from Shanghai to Jiangyin CHINA and Bill of Materials Substrate Core Change

Dear Customer,

This is notification of the STATS ChipPAC* Assembly Site Transfer from Shanghai to Jiangyin CHINA and Bill of Materials Substrate Core Change. STATS ChipPAC* was acquired by Jiangsu Changjiang Electronics Technology Co., Ltd. (JCET) in 2015. All assets will be consolidating to the JCET site location in Jiangyin CHINA targeted for the end of Q1_2017.

The described change(s) within this PCN will not take effect (i.e. Shipped) any earlier than **90** days from Initial PCN notification or the successful completion of the Cirrus Logic qualification, unless a customer agreement has been reached on an earlier implementation of the identified process change.

Cirrus Logic requests acknowledgement of receipt for this Initial PCN notification within 30 calendar days and acceptance of the identified change(s) within 90 days from receipt. Shipment of said material will commence after the 90 day period or upon successful completion of the Cirrus Logic defined qualification; lack of acknowledgement / communication is considered as acceptance.

Cirrus Logic would like to take this opportunity to thank our customers for their cooperation and assistance in this respective matter. Any specific or immediate inquiries should be directed to your local Field Sales Representative.

Sincerely,

Quality Systems Administrator
Cirrus Logic Corporate Quality
Phone: +1(512) 851-4000

* - STATS ChipPAC was acquired by Jiangsu Changjiang Electronics Technology Co., Ltd. (JCET) in 2015.



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PCN Notification Date: 09/30/2016

Products Affected:

The devices listed on this page are the complete list of affected devices. According to our records, one or more of these devices have been purchased by your organization within the past twenty-four (24) months. The corresponding customer part number is also listed, if available.

Technical details of this Process / Product Change follow on the next page(s).

Title:	STATS ChipPAC* Assembly Site Transfer from Shanghai to Jiangyin CHINA and Bill Of Materials Substrate Core Change			
Customer Contact:	Local Field Sales Representative	Phone:	(512) 851-4000	Dept: Corporate Quality
Proposed 1st Ship Date:	Q1_2017	Estimated Sample Availability Date:	Q1_2017	
Change Type:	Site Transfer: Change Type = Major, but considered Minor; as the subcontractor (STATS ChipPAC*) is an existing qualified supplier for Cirrus Logic and there are no changes to the equipment or material.			
X	Assembly Site		Assembly Process	Assembly Materials
	Wafer Fab Site		Wafer Fab Process	Wafer Fab Materials
	Wafer Bump Site		Wafer Bump Process	Wafer Bump Material
	Test Site		Test Process	Design
	Electrical Specification		Mechanical Specification	Part Number
	Packing/Shipping/Labeling	X	Other	
Comments:	Substrate Core Material Change			

PCN Details	
Description of Change:	
<p>Cirrus Logic is qualifying the STATS ChipPAC* Assembly Site Transfer from Shanghai to Jiangyin CHINA and Bill Of Materials Substrate Core Change.</p> <p>Below you will find an outline of the described changes for these components:</p> <p>Special Note: Change Type = Major, but considered Minor. The subcontractor (STATS ChipPAC*) is an existing qualified supplier.</p> <ul style="list-style-type: none"> BOM Change: Substrate Core Material From: CCL-HL832 Series (Halogenated) To: CCL-HL832NXA Series (Non-Halogenated) Reference: Appendix A – Substrate Material Comparison Information Assembly Site Change: From: STATS ChipPAC* site location in Shanghai CHINA To: STATS ChipPAC* site location in Jiangyin CHINA Note: All equipment associated with the Assembly processes will remain the same 	

PCN Number: PCN-2016-63

PCN Notification Date: 09/30/2016

Reason for Change:

STATS ChipPAC* was acquired by Jiangsu Changjiang Electronics Technology Co., Ltd. (JCET) in 2015. All assets will be consolidating to the JCET site location in Jiangyin CHINA targeted for the end of Q1_2017.

Special Note:

Earlier production level material may be available from the qualified Jiangyin CHINA site location, but shipment(s) from Cirrus Logic are contingent on successful qualification completion of the designated site transfer.

Anticipated Impact on Form, Fit, Function, Quality or Reliability:

No anticipated adverse impact to the Quality and/or Reliability of said product; as the transfer site is part of an already existing Cirrus Logic qualified subcontractor STATS ChipPAC* and there are no changes to the equipment or material.

Product Affected:

Cirrus Logic Part Number(s):

EP9307-CRZ[R]/E2
EP9307-IRZ[R]/E2

Changes To Product Identification Resulting From This PCN:

The Cirrus Logic component symbolization on the external face of the device reflects the designated Assembly Site location. The Assembly Site Code on the external face of the designated components will change. Specifically, the 1st two characters of the PackMark will change:

From: **"BA"** To: **"BB"**
 Note: All other symbolization will remain the same.

Top Side Mark:

Mark Lay-out	Top Side Brand	STATS ChipPAC (Shanghai CHINA)	STATS ChipPAC (Jiangyin CHINA)	Comparison Results
See Below Illustration	1st Line: Logo Line	CIRRUS	CIRRUS	Same
	2nd Line: Cirrus Part Number	EP9307-xRZx	EP9307-xRZx	Same
	3rd Line: Package Mark	(FFBARRLSYYWW) FF = Foundry Code AA = Assembly Site Code RR = Die Rev LS = Lot Sequence Code YY = Year of Manufacture WW = Work Week of Manufacture	(FFBBRRLSYWW) FF = Foundry Code AA = Assembly Site Code RR = Die Rev LS = Lot Sequence Code YY = Year of Manufacture WW = Work Week of Manufacture	Different

PCN Number: PCN-2016-63

PCN Notification Date: 09/30/2016

	4 th Line: ARM Logo	ARM	ARM	Same
	5 th Line: Country of Origin (COO)	CN	CN	Same

Note: *Lot code and Date code characters vary according to the lot and timeframe of build

Below is a 2D representative image of the Package: MF (Mark Format) = 242 Rev B




PACKAGE MARK FIELDS

12 character Package Mark appears on PO as 6 fields of 2 characters each in the following format:

FFAARRLSYYWW where,

- FF = Foundry Code
- AA = Assembly Site Code
- RR = Die Rev Code
- LS = Lot Sequence Code
- YY = Year of Manufacture
- WW = Work Week of Manufacture

TOP SIDE BRAND

- Line 1: Logo Line. Use  CIRRUS LOGIC logo as shown.
- Line 2: Part Number (12 spaces max.)
- Line 3: Package Mark (12 spaces max.)
- Line 4: ARM logo
- Line 5: Country of Origin (COO).

Family Qualification Data:

This qualification has been specifically developed for the validation of this change. The qualification data validates that the proposed change meets the applicable released technical specifications.

Qualification Schedule	Start:	Sep 2016	End:	Dec 2016
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Qualification Device Family Construction Details			
Detail Description	Device 1	Device 2	Device 3
Part Number(s):	EP9307-*RZ[R]	CS4208-CRZ[R]	JSCC Qual Vehicle
Die Size:	41.73 mm ²	21.98 mm ²	22.21 mm ²
Package Type/Code:	272 TFBGA	129 VFBGA	285 TFBGA
Mold Compound:	Sumitomo EME-G770LC	Kyocera KE-G1250LKDS	Sumitomo EME-G750S-E
Substrate Material:	2 layer, Substrate UMTC: 046043ESUB-A_00	2 layer, Substrate UMTC, 030848Jsub-A_07	4 layer, Substrate UMTC: 0.8P, 030356L_U2
Die Attach Material:	Ablebond 2000	Ablebond 2000	Ablebond 2300
Wire Material:	Au 2N	Cu Pd	EX1 Type (Cu Pd Coated)
Wire Size:	1.0 mil	0.8 mil	0.8 mil
Solder Ball Composition - Size:	Sn / 4% Ag / 0.5% Cu – 400um	Sn / 3% Ag / 0.5% Cu – 250um	Sn / 3% Ag / 0.5% Cu – 300um

PCN Number: PCN-2016-63

PCN Notification Date: 09/30/2016

The Qualification Plans are designed using JEDEC and other applicable industry standards. An overall summary of the Qualification results will be submitted upon completion.

Device Package Level Qualification Plan

Purpose
STATS ChipPAC* Package level Qualification for Assembly Site Transfer from Shanghai to Jiangyin CHINA

Stress Name	Stress Method	Conditions	# of Lots	Qty per Lot	Read Points	Failure Criteria	Results (PASS/FAIL)
PC (Pre-Condition)	JEDEC A113 Per component MSL classification per J-STD-020	Bake: 24Hr +125°C; MSL 3 192Hr 30°C / 60% RH Soak, (Reflow 260°C x 3)	5	Sufficient for stress test coverage	Precon MSL3	0 fails	
TC (Temperature Cycle)	JEDEC JESD22-A104	-40°C to +125°C for 850 cycles or -55°C to +125°C for 1000 cycles Post Precondition	5	77	850 or 1000 Cycles	0 fails	
THB / BHAST (Temperature- Humidity-Bias)	JEDEC JESD22-A101 and A110	85°C/85% RH/1000 Hrs / +110°C 85% RH 264 Hrs	4	77	1000 / 264 Hrs	0 fails	
UHAST (Unbiased HAST)	JEDEC JESD22-A118	+110°C/85% RH, 17.7 PSIA, 264Hrs	5	77	264 Hrs	0 fails	
HTSL (High Temperature Storage Life)	JEDEC JESD22-A103	+150°C for 1000Hrs	3	45	1000 Hrs	0 fails	
WBP (Wire Bond Pull)	MIL-STD-883 M2011	Paragraph 3 of Reference Specification Table 1 Figure 2011-2				0 fails	
WBS (Wire Bond Shear)	JESD22-B116					0 fails	
PPD (Package Physical Dimensions)	Case Outline Drawing				Meet all case outline drawing tolerances	No deviations from package drawing	

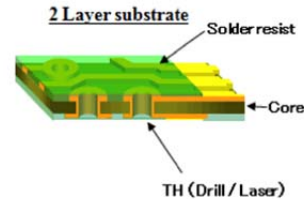
Notes:

- Qualification tests "pass" on zero fails for each test

Appendix A - Substrate Material Comparison Information

Nexus 2 Layer Substrate Cross Section

Layer	Current	New	
Top Pad Finish	Ni 5um Au 0.5 um (Min)	Ni 5um Au 0.5 um (Min)	No Change
Solder Mask	AUS303	AUS303	No Change
Copper Trace	Cu Foil 12 um Cu Plating 15 um	Cu Foil 12 um Cu Plating 15 um	No Change
Core Material	HL832	HL832NXA-EX	Changed
Copper Trace	Cu Foil 12 um Cu Plating 15 um	Cu Foil 12 um Cu Plating 15 um	No Change
Solder Mask	AUS303	AUS303	No Change
Bottom Pad Finish	Ni 5um Au 0.5 – 1.0 um	Ni 5um Au 0.5 – 1.0 um	No Change



Note: There are no changes to the Top/Bottom Pad, Solder Mask or Copper Trace material

Existing Non-NXA material versus NXA Core Material Comparison

Item	Condition	Unit	HL832	HL832NX type A	
Tg	DMA	degC	210	230	
	TMA	degC	180	200	
CTE	XY	< Tg	ppm/degC	15	14
		> Tg	ppm/degC	5	5
	Z	< Tg	ppm/degC	55	30
		> Tg	ppm/degC	220	140
Cu peel strength	12um Cu (UP)	kN/m	0.9	0.85	
Flexural strength	25degC	MPa	550	450	
Flexural modulus	25degC	GPa	24	28	
Tensile strength	25degC	MPa	320	270	
Youngs modulus	25degC	GPa	24	28	
Poisson ratio	25degC	-	0.18	0.19	
Thermal conductivity	25degC	W/mK	0.30	0.80	
Moisture absorption	C168/85/85	wt%	0.42	0.44	
Dielectric constant	1 GHz	-	4.3	4.9	
Dissipation factor	1 GHz	-	0.016	0.011	
Flame resistance (Green)	E-168 / 70	UL94	V-0 Halogenated	V-0 Non Halogenated	

Note: NXA material has a higher Tg, lower CTE and is Non-Halogenated